Features

- Single-voltage Operation
 - 5V Read
 - 5V Reprogramming
- Fast Read Access Time 45 ns
- Internal Program Control and Timer
- 8K Word Boot Block with Lockout
- Fast Erase Cycle Time 1.5 seconds
- Word-by-word Programming 10 µs/Word Typical
- Hardware Data Protection
- Data Polling for End of Program Detection
- Small 10 x 14 mm VSOP Package
- Typical 10,000 Write Cycles

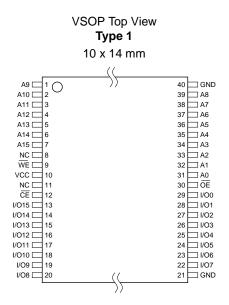
Description

The AT49F1024A is a 5-volt-only in-system Flash memory organized as 65,536 words by 16 bits. Manufactured with Atmel's advanced nonvolatile CMOS technology, the devices offer access times to 45 ns with power dissipation of just 275 mW over the commercial temperature range. When the device is deselected, the CMOS standby current is less than 100 μ A.

To allow for simple in-system reprogrammability, the AT49F1024A does not require high-input voltages for programming. Five-volt-only commands determine the read and programming operation of the device. Reading data out of the device is similar to reading from an EPROM. Reprogramming the AT49F1024A is performed by erasing a block of data (entire chip or main memory block) and then programming on a word-byword basis. The typical word programming time is a fast 10 µs. The end of a program cycle can be optionally detected by the Data Polling feature. Once the end of a byte program cycle has been detected, a new access for a read or program can begin. The typical number of program and erase cycles is in excess of 10,000 cycles.

Pin Configurations

| Pin Name | Function |
|--------------|---------------------|
| A0 - A15 | Addresses |
| CE | Chip Enable |
| ŌĒ | Output Enable |
| WE | Write Enable |
| I/O0 - I/O15 | Data Inputs/Outputs |
| NC | No Connect |





1-megabit (64K x 16) 5-volt Only Flash Memory

AT49F1024A

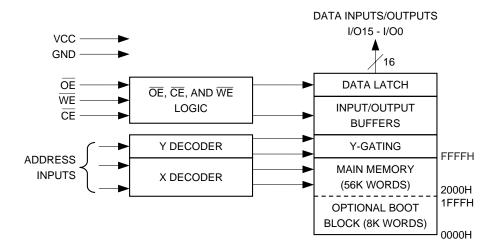






The optional 8K word boot block section includes a reprogramming write lockout feature to provide data integrity. The boot sector is designed to contain user secure code, and when the feature is enabled, the boot sector is permanently protected from being erased or reprogrammed.

Block Diagram



Device Operation

READ: The AT49F1024A is accessed like an EPROM. When \overline{CE} and \overline{OE} are low and \overline{WE} is high, the data stored at the memory location determined by the address pins is asserted on the outputs. The outputs are put in the high impedance state whenever \overline{CE} or \overline{OE} is high. This dual line control gives designers flexibility in preventing bus contention.

CHIP ERASE: When the boot block programming lockout feature is not enabled, the boot block and the main memory block will erase together from the same Chip Erase command (See Command Definitions table). If the boot block lockout function has been enabled, data in the boot section will not be erased. However, data in the main memory section will be erased. After a chip erase, the device will return to the read mode.

MAIN MEMORY ERASE: As an alternative to the chip erase, a main memory block erase can be performed, which will erase all words not located in the boot block region to an FFFFH. Data located in the boot region will not be changed during a main memory block erase. The Main Memory Erase command is a six-bus cycle operation. The address (555H) is latched on the falling edge of the sixth cycle while the 30H data input is latched on the rising edge of $\overline{\text{WE}}$. The main memory erase starts after the rising edge of $\overline{\text{WE}}$ of the sixth cycle. Please see main memory erase cycle waveforms. The main memory erase operation is internally controlled; it will automatically time to completion.

WORD PROGRAMMING: Once the memory array is erased, the device is programmed (to a logic "0") on a word-by-word basis. Please note that a data "0" cannot be programmed back to a "1"; only erase operations can convert "0"s to "1"s. Programming is accomplished via the internal device command register and is a four-bus cycle operation (please refer to the Command Definitions table). The device will automatically generate the required internal program pulses.

The program cycle has addresses latched on the falling edge of $\overline{\text{WE}}$ or $\overline{\text{CE}}$, whichever occurs last, and the data latched on the rising edge of $\overline{\text{WE}}$ or $\overline{\text{CE}}$, whichever occurs first. Programming is completed after the specified t_{BP} cycle time. The $\overline{\text{Data}}$ Polling feature may also be used to indicate the end of a program cycle.

BOOT BLOCK PROGRAMMING LOCKOUT: The device has one designated block that has a programming lockout feature. This feature prevents programming of data in the designated block once the feature has been enabled. The size of the block is 8K words. This block, referred to as the boot block, can contain secure code that is used to bring up the system. Enabling the lockout feature will allow the boot code to stay in the device while data in the rest of the device is updated. This feature does not have to be activated; the boot block's usage as a write-protected region is optional to the user. The address range of the boot block is 0000H to 1FFFH.

Once the feature is enabled, the data in the boot block can no longer be erased or programmed. Data in the main memory block can still be changed through the regular programming method and can be erased using either the Chip Erase or the Main Memory Block Erase command. To activate the lockout feature, a series of six program commands to specific addresses with specific data must be performed. Please refer to the Command Definitions table.

BOOT BLOCK LOCKOUT DETECTION: A software method is available to determine if programming of the boot block section is locked out. When the device is in the software product identification mode (see Software Product Identification Entry and Exit sections), a read from address location 0002H will show if programming the boot block is locked out. If the data on I/O0 is low, the boot block can be programmed; if the data on I/O0 is high, the program lockout feature has been activated and the block cannot be programmed. The software product identification exit code should be used to return to standard operation.

PRODUCT IDENTIFICATION: The product identification mode identifies the device and manufacturer as Atmel. It may be accessed by hardware or software operation. The hardware operation mode can be used by an external programmer to identify the correct programming algorithm for the Atmel product.

For details, see Operating Modes (for hardware operation) or Software Product Identification. The manufacturer and device code is the same for both modes.

DATA POLLING: The AT49F1024A features Data Polling to indicate the end of a program or erase cycle. During a program cycle, an attempted read of the last byte loaded will result in the complement of the loaded data on I/O7. Once the program cycle has been completed, true data is valid on all outputs and the next cycle may begin. Data Polling may begin at any time during the program cycle.

TOGGLE BIT: In addition to Data Polling, the AT49F1024A provides another method for determining the end of a program or erase cycle. During a program or erase operation, successive attempts to read data from the device will result in I/O6 toggling between one and zero. Once the program cycle has completed, I/O6 will stop toggling and valid data will be read. Examining the toggle bit may begin at any time during a program cycle.

HARDWARE DATA PROTECTION: Hardware features protect against inadvertent programs to the AT49F1024A in the following ways: (a) V_{CC} sense: if V_{CC} is below 3.8V (typical), the program function is inhibited. (b) Program inhibit: holding any one of \overline{OE} low, \overline{CE} high or \overline{WE} high inhibits program cycles. (c) Noise filter: pulses of less than 15 ns (typical) on the \overline{WE} or \overline{CE} inputs will not initiate a program cycle.





Command Definition (in Hex)

| Command | Bus | | Bus cle | 2nd l Cyc | | | Bus cle | 4th Cy | | 5th Cy | | 6th Cy | |
|--------------------------------------|--------|------|------------------|--------------------|------|------|------------|-----------|-----------------|-----------|------|-----------|------|
| Sequence | Cycles | Addr | Data | Addr | Data | Addr | Data | Addr | Data | Addr | Data | Addr | Data |
| Read | 1 | Addr | D _{OUT} | | | | | | | | | | |
| Chip Erase | 6 | 555 | AA | AAA ⁽²⁾ | 55 | 555 | 80 | 555 | AA | AAA | 55 | 555 | 10 |
| Main Memory Erase | 6 | 555 | AA | AAA | 55 | 555 | 80 | 555 | AA | AAA | 55 | 555 | 30 |
| Word Program | 4 | 555 | AA | AAA | 55 | 555 | A0 | Addr | D _{IN} | | | | |
| Boot Block Lockout ⁽³⁾ | 6 | 555 | AA | AAA | 55 | 555 | 80 | 555 | AA | AAA | 55 | 555 | 40 |
| Product ID Entry | 3 | 555 | AA | AAA | 55 | 555 | 90 | | | | | | |
| Product ID Exit ⁽⁴⁾ | 3 | 555 | AA | AAA | 55 | 555 | F0 | | | | | | |
| Product ID Exit ⁽⁴⁾ | 1 | xxx | F0 | | | | | | | | | | |

Notes: 1. The DATA FORMAT in each bus cycle is as follows: I/O15 - I/O8 (Don't Care); I/O7 - I/O0 (Hex).

The ADDRESS FORMAT in each bus cycle is as follows: A11 - A0 (Hex); A11 - A15 (Don't Care).

- 2. Since A11 is a Don't Care, AAA can be replaced with 2AA.
- 3. The 8K word boot sector has the address range 0000H to 1FFFH.
- 4. Either one of the Product ID Exit commands can be used.

Absolute Maximum Ratings*

| Temperature under Bias55°C to +125°C |
|---|
| Storage Temperature65°C to +150°C |
| All Input Voltages (including NC Pins) with Respect to Ground0.6V to +6.25V |
| All Output Voltages with Respect to Ground0.6V to V _{CC} + 0.6V |
| Voltage on $\overline{\text{OE}}$ with Respect to Ground0.6V to +13.5V |

*NOTICE:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

DC and AC Operating Range

| | AT49F1024A-45 | |
|------------------------------|---------------|------------|
| Operating Temperature (Case) | Com. | 0°C - 70°C |
| V _{CC} Power Supply | | 5V ± 10% |

Operating Modes

| Mode | CE | ŌĒ | WE | Ai | I/O |
|-------------------------|----------|------------------|-----------------|--|----------------------------------|
| Read | V_{IL} | V_{IL} | V _{IH} | Ai | D _{OUT} |
| Program ⁽²⁾ | V_{IL} | V_{IH} | V _{IL} | Ai | D _{IN} |
| Standby/Write Inhibit | V_{IH} | X ⁽¹⁾ | X | X | High-Z |
| Program Inhibit | Х | Х | V _{IH} | | |
| Program Inhibit | Х | V _{IL} | Х | | |
| Output Disable | Х | V_{IH} | Х | | High-Z |
| Product Identification | | | | | |
| Handware | | | | A1 - A15 = V _{IL} , A9 = V _H ⁽³⁾ , A0 = V _{IL} | Manufacturer Code ⁽⁴⁾ |
| Hardware | V_{IL} | V_{IL} | V _{IH} | A1 - A15 = V _{IL} , A9 = V _H ⁽³⁾ , A0 = V _{IH} | Device Code ⁽⁴⁾ |
| Software ⁽⁵⁾ | | | | A0 = V _{IL} , A1 - A15 = V _{IL} | Manufacturer Code ⁽⁴⁾ |
| Software | | | | A0 = V _{IH} , A1 - A15 = V _{IL} | Device Code ⁽⁴⁾ |

- Notes: 1. X can be V_{IL} or V_{IH}. 2. Refer to AC programming waveforms.
 - 3. $V_H = 12.0V \pm 0.5V$.
 - 4. Manufacturer Code: 001FH, Device Code: 0087H.
 - 5. See details under "Software Product Identification Entry/Exit" on page 11.

DC Characteristics

| Symbol | Parameter | Condition | Min | Max | Units |
|--------------------------------|--------------------------------------|---|-----|-------|-------|
| ILI | Input Load Current | $V_{IN} = 0V \text{ to } V_{CC}$ | | 10.0 | μA |
| I _{LO} | Output Leakage Current | V _{I/O} = 0V to V _{CC} | | 10.0 | μA |
| I _{SB1} | V _{CC} Standby Current CMOS | $\overline{\text{CE}} = \text{V}_{\text{CC}} - 0.3 \text{V to V}_{\text{CC}}$ | | 100.0 | μA |
| I _{SB2} | V _{CC} Standby Current TTL | $\overline{\text{CE}}$ = 2.0V to V _{CC} | | 1.0 | mA |
| I _{CC} ⁽¹⁾ | V _{CC} Active Current | f = 5 MHz; I _{OUT} = 0 mA | | 50.0 | mA |
| V _{IL} | Input Low Voltage | | | 0.8 | V |
| V _{IH} | Input High Voltage | | 2.0 | | V |
| V _{OL} | Output Low Voltage | I _{OL} = 2.1 mA | | 0.45 | V |
| V _{OH1} | Output High Voltage | I _{OH} = -400 μA | 2.4 | | V |
| V _{OH2} | Output High Voltage CMOS | $I_{OH} = -100 \ \mu A; \ V_{CC} = 4.5 V$ | 4.2 | | V |

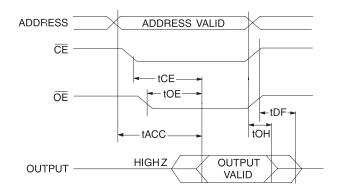
1. In the erase mode, $\rm I_{\rm CC}$ is 90 mA. Note:



AC Read Characteristics

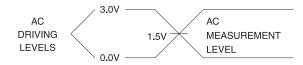
| | | AT49F1024A-45 | | |
|-----------------------------------|--|---------------|-----|-------|
| Symbol | Parameter | Min | Max | Units |
| t _{ACC} | Address to Output Delay | | 45 | ns |
| t _{CE} ⁽¹⁾ | CE to Output Delay | | 45 | ns |
| t _{OE} ⁽²⁾ | OE to Output Delay | 0 | 30 | ns |
| t _{DF} ⁽³⁾⁽⁴⁾ | CE or OE to Output Float | 0 | 25 | ns |
| t _{OH} | Output Hold from OE, CE or Address, whichever occurred first | 0 | | ns |

AC Read Waveforms⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾



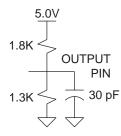
- Notes: 1. \overline{\overline{CE}} \text{ may be delayed up to \$t_{ACC}\$ \$t_{CE}\$ after the address transition without impact on \$t_{ACC}\$.
 QE may be delayed up to \$t_{CE}\$ \$t_{OE}\$ after the falling edge of \overline{CE}\$ without impact on \$t_{CE}\$ or by \$t_{ACC}\$ \$t_{OE}\$ after an address change without impact on \$t_{ACC}\$.
 \$t_{DF}\$ is specified from \overline{OE}\$ or \overline{CE}\$, whichever occurs first \$(C_L = 5 \text{ pF})\$.
 This parameter is characterized and is not 100% tested.

Input Test Waveforms and Measurement Level



 t_R , $t_F < 5$ ns

Output Test Load



Pin Capacitance

 $f = 1 \text{ MHz}, T = 25^{\circ}C^{(1)}$

| Symbol | Тур | Max | Units | Conditions |
|------------------|-----|-----|-------|-----------------------|
| C _{IN} | 4 | 6 | pF | $V_{IN} = 0V$ |
| C _{OUT} | 8 | 12 | pF | V _{OUT} = 0V |

Note: 1. This parameter is characterized and is not 100% tested.

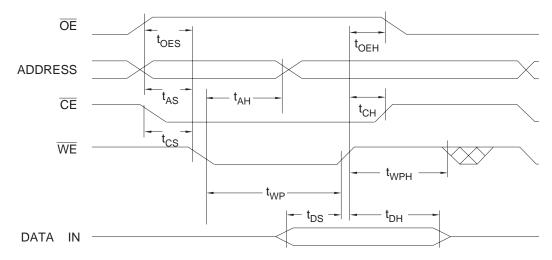


AC Word Load Characteristics

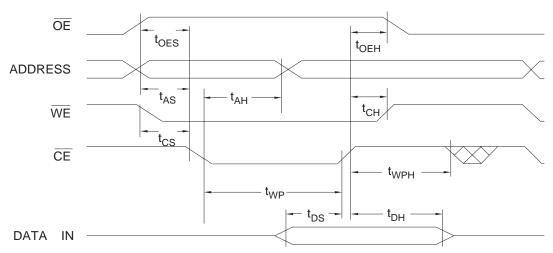
| Symbol | Parameter | Min | Max | Units |
|------------------------------------|------------------------------|-----|-----|-------|
| t _{AS} , t _{OES} | Address, OE Setup Time | 0 | | ns |
| t _{AH} | Address Hold Time | 50 | | ns |
| t _{CS} | Chip Select Setup Time | 0 | | ns |
| t _{CH} | Chip Select Hold Time | 0 | | ns |
| t _{WP} | Write Pulse Width (WE or CE) | 50 | | ns |
| t _{DS} | Data Setup Time | 50 | | ns |
| t _{DH} , t _{OEH} | Data, OE Hold Time | 0 | | ns |
| t _{WPH} | Write Pulse Width High | 40 | | ns |

AC Word Load Waveforms

WE Controlled



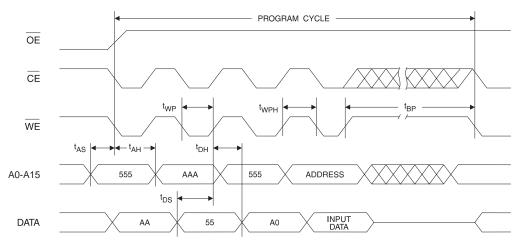
CE Controlled



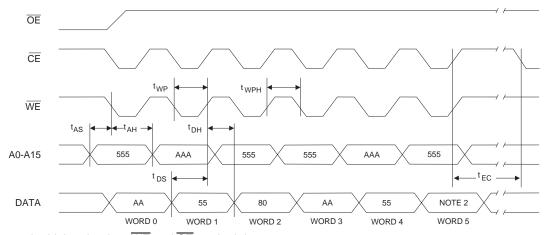
Program Cycle Characteristics

| Symbol | Parameter | Min | Тур | Max | Units |
|------------------|------------------------|-----|-----|-----|---------|
| t _{BP} | Word Programming Time | | 10 | 50 | μs |
| t _{AS} | Address Setup Time | 0 | | | ns |
| t _{AH} | Address Hold Time | 50 | | | ns |
| t _{DS} | Data Setup Time | 50 | | | ns |
| t _{DH} | Data Hold Time | 0 | | | ns |
| t _{WP} | Write Pulse Width | 50 | | | ns |
| t _{WPH} | Write Pulse Width High | 40 | | | ns |
| t _{EC} | Erase Cycle Time | | 1.5 | 3 | seconds |

Program Cycle Waveforms



Main Memory or Chip Erase Cycle Waveforms



Notes: 1. \overline{OE} must be high only when \overline{WE} and \overline{CE} are both low.

2. For chip erase, the address should be 10H. For a main memory erase, the data should be 30H.





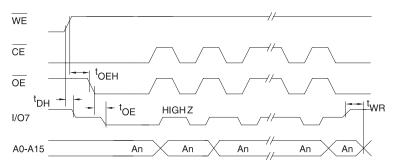
Data Polling Characteristics⁽¹⁾

| Symbol | Parameter | Min | Тур | Max | Units |
|------------------|-----------------------------------|-----|-----|-----|-------|
| t _{DH} | Data Hold Time | 10 | | | ns |
| t _{OEH} | OE Hold Time | 10 | | | ns |
| t _{OE} | OE to Output Delay ⁽²⁾ | | | | ns |
| t _{WR} | Write Recovery Time | 0 | | | ns |

Notes: 1.

- 1. These parameters are characterized and not 100% tested.
- 2. See t_{OE} spec in "AC Read Characteristics" on page 6.

Data Polling Waveforms



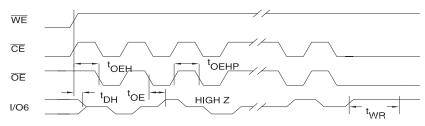
Toggle Bit Characteristics(1)

| Symbol | Parameter | Min | Тур | Max | Units |
|-------------------|--|-----|-----|-----|-------|
| t _{DH} | Data Hold Time | 10 | | | ns |
| t _{OEH} | OE Hold Time | 10 | | | ns |
| t _{OE} | \overline{OE} to Output Delay ⁽²⁾ | | | | ns |
| t _{OEHP} | OE High Pulse | 150 | | | ns |
| t _{WR} | Write Recovery Time | 0 | | | ns |

Notes: 1

- 1. These parameters are characterized and not 100% tested.
- 2. See t_{OE} spec in "AC Read Characteristics" on page 6.

Toggle Bit Waveforms⁽¹⁾⁽²⁾⁽³⁾



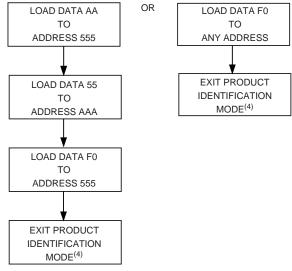
Notes:

- 1. Toggling either $\overline{\text{OE}}$ or $\overline{\text{CE}}$ or both $\overline{\text{OE}}$ and $\overline{\text{CE}}$ will operate toggle bit. The t_{OEHP} specification must be met by the toggling input(s).
- 2. Beginning and ending state of I/O6 will vary.
- 3. Any address location may be used but the address should not vary.

Software Product Identification Entry⁽¹⁾

LOAD DATA AA TO ADDRESS 555 LOAD DATA 55 TO ADDRESS AAA LOAD DATA 90 TO ADDRESS 555 ENTER PRODUCT IDENTIFICATION MODE⁽²⁾⁽³⁾⁽⁵⁾

Software Product Identification Exit⁽¹⁾



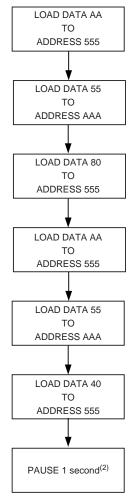
Notes: 1. Data Format: I/O15 - I/O8 (Don't Care); I/O7 - I/O0 (Hex).

Address Format: A11 - A0 (Hex); A11 - A15 (Don't Care).

2. A1 - A15 = V_{IL} . Manufacturer Code is read for A0 = V_{IL} . Device Code is read for A0 = V_{IH} .

- The device does not remain in identification mode if powered down.
- 4. The device returns to standard operation mode.
- Manufacturer Code: 001FH Device Code: 0087H

Boot Block Lockout Enable Algorithm(1)



Notes: 1. Data Format: I/O15 - I/O8 (Don't Care); I/O7 - I/O0 (Hex).

Address Format: A11 - A0 (Hex); A11 - A15 (Don't Care).

2. Boot Block Lockout feature enabled.



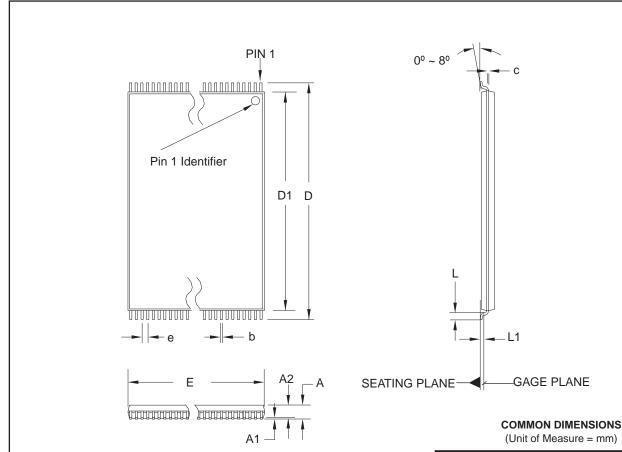
AT49F1024A Ordering Information

| t _{ACC} (ns) | I _{CC} (mA) | | | | |
|--------------------------|----------------------|---------|------------------------------|---------|-----------------------------|
| | Active | Standby | Ordering Code | Package | Operation Range |
| 45 | 50 | 0.1 | AT49F1024A-45VC | 40V | Commercial (0° to 70° C) |
| 45 | 50 | 0.1 | AT49F1024A-45VL Lead Free | 40V | Commercial (0° to 70° C) |

| Package Type | | | | | | |
|--------------|---|--|--|--|--|--|
| 40V | 40-lead, 10 mm x 14 mm, Thin Small Outline Package (VSOP) | | | | | |

Packaging Information

40V - VSOP

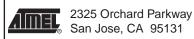


Notes:

- 1. This package conforms to JEDEC reference MO-142, Variation CA.
- Dimensions D1 and E do not include mold protrusion. Allowable protrusion on E is 0.15 mm per side and on D1 is 0.25 mm per side.
- 3. Lead coplanarity is 0.10 mm maximum.

| MIN | NOM | MAX | NOTE |
|-------|---|---|---|
| - | _ | 1.20 | |
| 0.05 | - | 0.15 | |
| 0.95 | 1.00 | 1.05 | |
| 13.80 | 14.00 | 14.20 | |
| 12.30 | 12.40 | 12.50 | Note 2 |
| 9.90 | 10.00 | 10.10 | Note 2 |
| 0.50 | 0.60 | 0.70 | |
| (| | | |
| 0.17 | 0.22 | 0.27 | |
| 0.10 | _ | 0.21 | |
| (| | | |
| | - 0.05 0.95 13.80 12.30 9.90 0.50 | 0.05 - 0.95 1.00 13.80 14.00 12.30 12.40 9.90 10.00 0.50 0.60 0.25 BASIG 0.17 0.22 0.10 - | - - 1.20 0.05 - 0.15 0.95 1.00 1.05 13.80 14.00 14.20 12.30 12.40 12.50 9.90 10.00 10.10 0.50 0.60 0.70 0.25 BASIC 0.17 0.22 0.27 |

10/18/01



TITLE

 $\bf 40V,$ 40-lead (10 x 14 mm Package) Plastic Thin Small Outline Package, Type I (VSOP)

DRAWING NO. REV. 40V B





Atmel Corporation

2325 Orchard Parkway San Jose, CA 95131, USA Tel: 1(408) 441-0311

Fax: 1(408) 487-2600

Regional Headquarters

Europe

Atmel Sarl Route des Arsenaux 41 Case Postale 80 CH-1705 Fribourg Switzerland

Tel: (41) 26-426-5555 Fax: (41) 26-426-5500

Asia

Room 1219 Chinachem Golden Plaza 77 Mody Road Tsimshatsui East Kowloon Hong Kong

Tel: (852) 2721-9778 Fax: (852) 2722-1369

Japan

9F, Tonetsu Shinkawa Bldg. 1-24-8 Shinkawa Chuo-ku, Tokyo 104-0033

Tel: (81) 3-3523-3551 Fax: (81) 3-3523-7581

Atmel Operations

Memory

2325 Orchard Parkway San Jose, CA 95131, USA Tel: 1(408) 441-0311 Fax: 1(408) 436-4314

Microcontrollers

2325 Orchard Parkway San Jose, CA 95131, USA Tel: 1(408) 441-0311 Fax: 1(408) 436-4314

La Chantrerie BP 70602

44306 Nantes Cedex 3, France

Tel: (33) 2-40-18-18-18 Fax: (33) 2-40-18-19-60

ASIC/ASSP/Smart Cards

Zone Industrielle 13106 Rousset Cedex, France Tel: (33) 4-42-53-60-00

Fax: (33) 4-42-53-60-01

1150 East Cheyenne Mtn. Blvd. Colorado Springs, CO 80906, USA

Tel: 1(719) 576-3300 Fax: 1(719) 540-1759

Scottish Enterprise Technology Park Maxwell Building East Kilbride G75 0QR, Scotland

Tel: (44) 1355-803-000 Fax: (44) 1355-242-743

RF/Automotive

Theresienstrasse 2 Postfach 3535 74025 Heilbronn, Germany Tel: (49) 71-31-67-0

Fax: (49) 71-31-67-2340

1150 East Cheyenne Mtn. Blvd. Colorado Springs, CO 80906, USA

Tel: 1(719) 576-3300 Fax: 1(719) 540-1759

Biometrics/Imaging/Hi-Rel MPU/ High Speed Converters/RF Datacom

Avenue de Rochepleine

BP 123

38521 Saint-Egreve Cedex, France

Tel: (33) 4-76-58-30-00 Fax: (33) 4-76-58-34-80

Literature Requests www.atmel.com/literature

Disclaimer: Atmel Corporation makes no warranty for the use of its products, other than those expressly contained in the Company's standard warranty which is detailed in Atmel's Terms and Conditions located on the Company's web site. The Company assumes no responsibility for any errors which may appear in this document, reserves the right to change devices or specifications detailed herein at any time without notice, and does not make any commitment to update the information contained herein. No licenses to patents or other intellectual property of Atmel are granted by the Company in connection with the sale of Atmel products, expressly or by implication. Atmel's products are not authorized for use as critical components in life support devices or systems.

© Atmel Corporation 2003. All rights reserved. Atmel® and combinations thereof are the registered trademarks of Atmel Corporation or its subsidiaries. Other terms and product names may be the trademarks of others.

